

SDM3045X Digital Multimeter



Product Overview

SDM3045X is a 4½ digit digital (60000 count) multimeter incorporating a dual-display and is especially well suited for the needs of high-precision, multifunction and automatic measurement.

Main Function

Basic Measurement Function

- ⚡ DC Voltage: 600 mV ~ 1000 V
- ⚡ DC Current: 600 μA ~ 10 A
- ⚡ AC Voltage: True-RMS, 600 mV ~ 750 V
- ⚡ AC Current: True-RMS, 60 mA ~ 10 A
- ⚡ 2/4-Wire Resistance: 600 Ω ~ 100 MΩ
- ⚡ Capacitance: 2 nF ~ 10000 μF
- ⚡ Continuity Test: Range is fixed at 2 kΩ
- ⚡ Diode Test: Adjustable range is 0~4 V.
- ⚡ Frequency Measurement: 20 Hz ~ 500 KHz
- ⚡ Period Measurement: 2 μs ~ 0.05 s
- ⚡ Temperature: Support for TC and RTD sensor
- ⚡ Max, Min, Average, Standard Deviation,
dBm/dB, Relative Measurement ,Pass/Fail
Histogram, Trend Chart

User-friendly Design

4.3" TFT-LCD, 480*272

Support dual display, Chinese and English Menu

Built-in front panel accessible help system

File management (support for U-disc and local storage)

Application fields

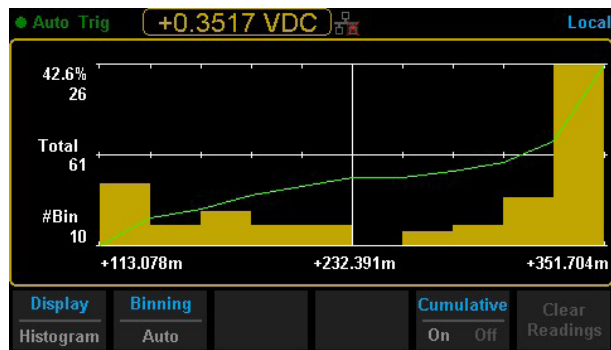
- ⚡ Research Laboratory
- ⚡ Development Laboratory
- ⚡ Detection and Maintenance
- ⚡ Calibration Laboratory
- ⚡ Automatic Production Test

Main Feature

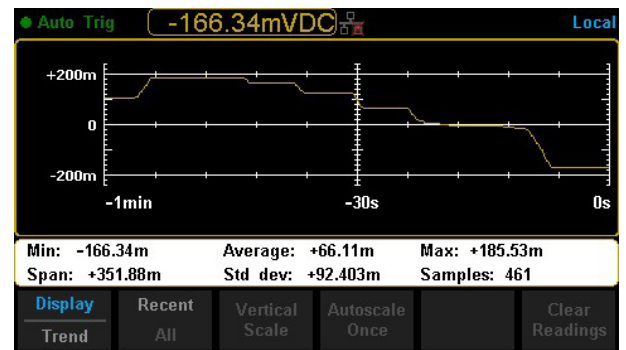
- ⚡ Real 4½ digit (60000 count) readings resolution
- ⚡ Up to 150 rdgs/s measurement speed
- ⚡ True-RMS AC Voltage and AC Current measuring
- ⚡ 1 Gb NAND flash size, Mass storage configuration files and data files
- ⚡ Built-in cold terminal compensation for thermocouple
- ⚡ With easy, convenient and flexible PC software: EasySDM
- ⚡ Standard interface: USB Device, USB Host, LAN
- ⚡ USB & LAN remote interfaces support common SCPI command set. Compatible with other popular DMMs on the market.

Special Features

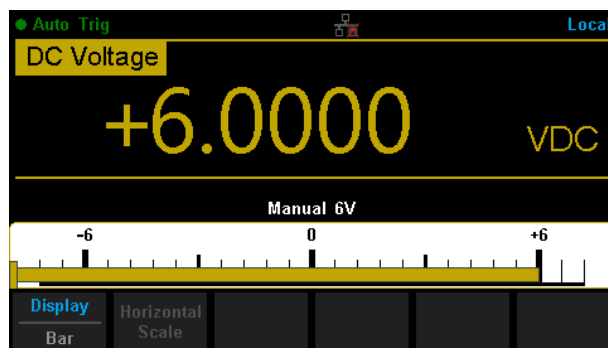
Histogram



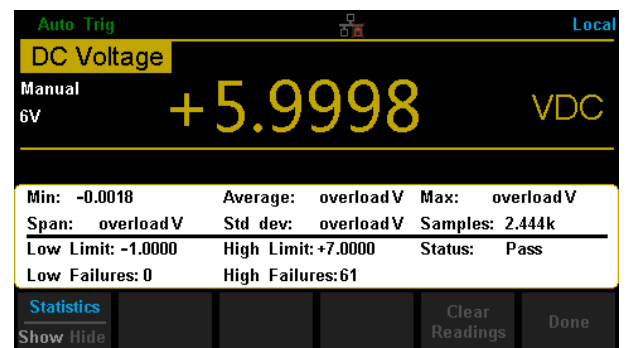
Trend Chart



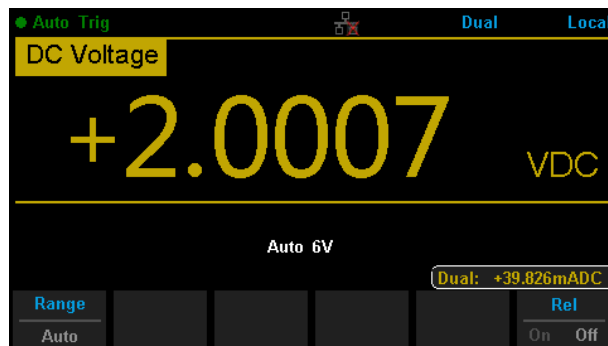
Bar Chart



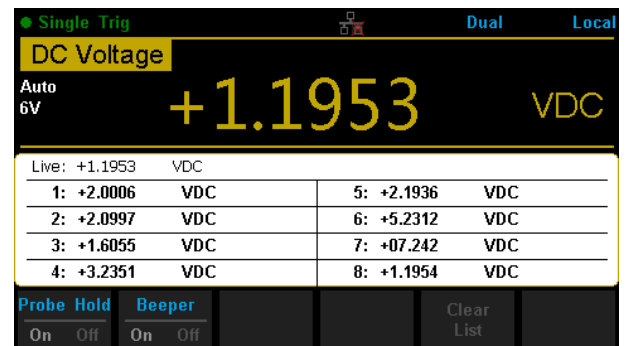
Statistics



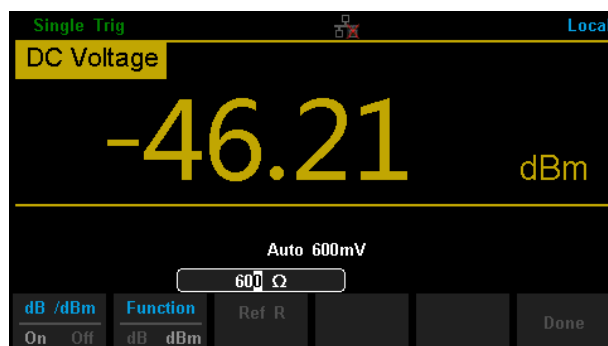
Dual Display



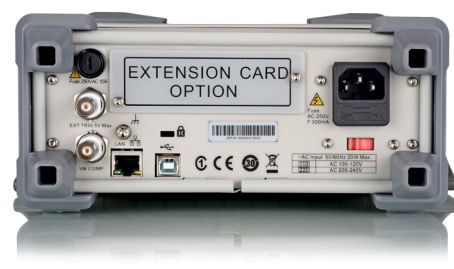
Hold Measurement



dBm Hold Measurement



Interface



Specifications

DC Characteristic

Accuracy ± (% of Reading + count)^[1]

Function	Range ^[2]	Test current or Load voltage	Resolution	Accuracy (one year; 23°C ±5°C)
DC Voltage	600 mV		0.01 mV	0.01+ 5
	6 V		0.0001 V	0.01+ 6
	60 V		0.001 V	0.02+ 4
	600 V		0.01 V	0.02+ 6
	1000 V ^[4]		0.1 V	0.02+ 6
DC Current	600 μA	< 33 mV	0.01 μA	0.05+ 3
	6 mA	< 330 mV	0.0001 mA	0.05+ 3
	60 mA	< 0.05 V	0.001 mA	0.05+ 3
	600 mA	< 0.5 V	0.01 mA	0.12+ 6
	6 A	< 0.33 V	0.0001 A	0.20+ 5
	10 A ^[5]	< 0.6 V	0.001 A	0.25+ 4
Resistance ^[3]	600 Ω	1 mA	0.01 Ω	0.04+ 5
	6 KΩ	1 00 μA	0.0001 KΩ	0.02+ 5
	60 KΩ	10 μA	0.001 KΩ	0.02+ 5
	600 KΩ	1 μA	0.01 KΩ	0.04+ 5
	6 MΩ	200 nA	0.0001 MΩ	0.12+ 3
	60 MΩ	200 nA 10 MΩ	0.001 MΩ	0.85+ 3
	100 MΩ	200 nA 10 MΩ	0.01 MΩ	1.75+ 3
Diode Test ^[6]	0~2 V	1 mA	0.0001 V	0.05+ 3
	2~4 V	1 mA	0.0001 V	0.35+ 3
Continuity Test	2000 Ω	1 mA	0.1 Ω	0.05+ 3

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C ~ 28°C .

[2] 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for 4-wire measure or 2-wire measure under "REF" operation. ±0.2 Ω of extra errors will be generated if perform 2-wire measure without "REF" operation.

[4] Plus 0.02 mV of error per 1 V after the first ±500 VDC.

[5] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.

[6] Accuracy specifications are only for voltage measuring at input terminal. The typical value of current under measure is 1 mA. Voltage drop at diode junction may vary with current supply. Adjustable voltage range : 0~ 4 V.



AC Characteristic

Accuracy± (% of Reading + count)^[1]

Function	Range ^[2]	Frequency Range	Resolution	Accuracy (one year; 23°C ±5°C)
True-RMS AC Voltage ^[3]	600 mV	20 Hz – 45 Hz	0.01 mV	2.0 + 20
		45 Hz – 100 Hz	0.01 mV	0.6 +10
		100 Hz – 20 KHz	0.01 mV	0.2 + 10
		20 KHz – 50 KHz	0.01 mV	1.0 + 10
		50 KHz –100 KHz	0.01 mV	3.0 + 10
	6 V	20 Hz – 45 Hz	0.0001 V	2.0 + 20
		45 Hz – 100 Hz	0.0001 V	0.6 + 10
		100 Hz – 20 KHz	0.0001 V	0.2 + 10
		20 KHz – 50 KHz	0.0001 V	1.0 + 10
		50 KHz –100 KHz	0.0001 V	3.0 + 10
	60 V	20 Hz – 45 Hz	0.001 V	2.0 + 20
		45 Hz – 100 Hz	0.001 V	0.6 +10
		100 Hz – 20 KHz	0.001 V	0.2 + 10
		20 KHz – 50 KHz	0.001 V	1.0 + 10
		50 KHz –100 KHz	0.001 V	3.0 + 10
	600 V	20 Hz – 45 Hz	0.01 V	2.0 + 20
		45 Hz – 100 Hz	0.01 V	0.6 + 10
		100 Hz – 20 KHz	0.01 V	0.2 + 10
		20 KHz – 50 KHz	0.01 V	1.0 + 10
		50 KHz –100 KHz	0.01 V	3.0 + 10
750 V	20 Hz – 45 Hz	0.01 V	2.0 + 20	
	45 Hz – 100 Hz ^[4]	0.01 V	0.6 + 10	
	100 Hz – 20 KHz	0.01 V	0.2 + 10	
	20 KHz – 50 KHz	0.01 V	1.0 + 10	
	50 KHz –100 KHz	0.01 V	3.0 + 10	
True-RMS AC Current ^[5]	60 mA	20 Hz – 45 Hz	0.001 mA	2.0 + 20
		45 Hz – 2 KHz	0.001 mA	0.5 + 20
		2 KHz – 10 KHz	0.001 mA	2.5 + 30
	600 mA	20 Hz – 45 Hz	0.01 mA	2.0 + 20
		45 Hz – 2 KHz	0.01 mA	0.5 + 20
		2 KHz – 10 KHz	0.01 mA	2.5 + 30
	6 A	20 Hz – 45 Hz	0.0001 A	2.0 + 20
		45 Hz – 2 KHz	0.0001 A	0.5 + 20
		2 KHz – 10 KHz	0.0001 A	2.5 + 20
	10 A ^[6]	20 Hz – 45 Hz	0.001 A	1.5 + 15
		45 Hz – 2 KHz	0.001 A	0.5 + 15
		2 KHz – 10 KHz	0.001 A	2.5 + 25

Additional wave crest factor error (not Sine) ^[7]

Wave crest coefficient	Error (% Range)
1-2	0.05
2-3	0.3

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C ~ 28°C .

[2] 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for amplitude of sine wave input > 5% of range. For inputs from 1% to 5% of range and <50 kHz, add 0.1% of range extra error. For 50 kHz to 100 kHz, add 0.1% of range extra error.

[4] Plus 0.025 V of error per 1 V after the first ±400 VAC.

[5] Specifications are for sine wave input > 5% of range. 0.1% errors will be added when the range of input sine wave is 1% to 5%.

[6] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.

[7] For inputs Frequency Range < 100 Hz

Frequency and Period Characteristic

Accuracy± (% of Reading + count)^[1]

Function	Range	Frequency Range	Resolution	Accuracy (one year; 23°C ±5°C)
Frequency /Period	600 mV to 750 V ^[2]	20 Hz – 2 KHz		0.01+3
		2 KHz – 20 KHz		0.01+2
		20 KHz – 200 KHz		0.01+2
		200 KHz –500 KHz		0.01+2

Remarks:

[1] Specifications are for 0.5 Hour warm-up.

[2] Except for special marks, the AC input voltage is 5% to 110% of range when <100 kHz and 10% to 110% of range when >100 kHz. 750 V range is limited to 750 Vrms. The accuracy is 10 times % of Reading when the measurement range of AC voltage is in 600 mV range.

Capacitance Characteristic

Accuracy± (% of Reading + count)^[1]

Function	Range ^[2]	Max Testing Current	Resolution	Accuracy (one year; 23°C ±5°C)
Capacitance	2 nF	10 µA	0.001 nF	3+10
	20 nF	10 µA	0.01 nF	1+10
	200 nF	100 µA	0.1 nF	1+9
	2 µF	100 µA	0.001 µF	1+10
	20 µF	1 mA	0.01 µF	1+10
	200 µF	1 mA	0.1 µF	1+9
	10000 µF	1 mA	1 µF	2+50

Remarks:

[1] Specifications are for 0.5 Hour warm-up and "REF" operation. Using of non-film capacitor may generate additional errors.

[2] Specifications are for from 1% to 110% on 2 nF range and ranges from 10% to 110% on other ranges.

Temperature Characteristic

Accuracy± (% of Reading)^[1]

Function	Probe Type	Probe Model	Working Temperature Range	Accuracy (one year; 23°C ±5°C)	Temperature coefficient 0°C ~ 18°C 28°C ~ 5 0°C
Temperature	RTD ^[2]	α=0.00385	-200°C ~ 660°C	0.16°C	0.09°C
		B	0°C ~ 1820°C	0.76°C	0.14°C
	TC ^[3]	E	-270°C ~ 1000°C	0.5°C	0.02°C
		J	-210°C ~ 1200°C	0.5°C	0.02°C
		K	-270°C ~ 1370°C	0.5°C	0.03°C
		N	-270°C ~ 1300°C	0.5°C	0.04°C
		R	-50°C ~ 1760°C	0.5°C	0.09°C
		S	-50°C ~ 1760°C	0.6°C	0.11°C
		T	-270°C ~ 400°C	0.5°C	0.03°C

Remarks:

[1] Specifications are for 0.5 Hour warm-up, not include probe error.

[2] Specifications are for 4-wire measure or 2-wire measure under "REF" operation.

[3] Built-in cold terminal compensation for thermocouple, accuracy is ±2°C .

Measuring Method and other Characteristics

DC Voltage		
Input Resistance	600 mV	10 M Ω or 10 G Ω selectable
	6 V, 60 V, 600 V and 1000 V Range	10 M Ω \pm 2%
Input Bias Current	<90 pA, 25°C	
Input Protection	1000 V on all ranges	
CMRR	120 dB (For the 1 K Ω unbalanced resistance in LO lead, max \pm 500 VDC)	
NMRR	60 dB at "slow" measurement rate	
Resistance		
Testing Method	4-wire resistance or 2-wire resistance selectable	
Input Protection	1000 V on all ranges	
DC Current		
Shunt Resistor	600 μ A sampling voltage < 33 mV	
	6 mA sampling voltage < 0.33 V	
	1 Ω for 60 mA, 600 mA 1 Ω	
	0.01 Ω for 6 A, 10 A	
Input Protection	Rear panel : accessible 10 A, 250 V fast-melt fuse	
	Internal : 12 A, 250 V slow-melt fuse	
Continuity/Diode Test		
Measurement Method	1 mA \pm 5% constant-current source or open-circuit voltage	
Beeper	yes	
Continuity Threshold	Adjustable	
Input Protection	1000 V	
True-RMS AC Voltage		
Measurement Method	AC Coupled true RMS measure – up to 1000 V DC bias are permitted on every range.	
Wave Crest Factor	\leq 3 at full scale	
Input Impedance	1 M Ω \pm 2% in parallel with <100 pF on all ranges	
AC Filter Bandwidth	20 Hz ~ 100 KHz	
CMRR	60 dB (For the 1 K Ω imbalance resistance among Lo lead and <60 Hz, Max \pm 500 VDC)	
True-RMS AC Current		
Measurement Method	DC Coupled to the fuse and shunt; AC Coupled the True-RMS measurement (measures the AC components only)	
Wave Crest Factor	\leq 3 at full scale	
Max Input	<10 A (include DC component)	
Shunt Resistor	1 Ω for 60 mA, 600 mA 1 Ω ; 0.01 Ω for 6 A, 10 A	
Input Protection	Rear panel : accessible 10 A, 250 V fast-melt fuse	
	Internal : 12 A, 250 V slow-melt fuse	
Frequency/Period		
Measurement Method	Reciprocal-counting technique, AC Coupled input, AC voltage or AC current measurement function	
Measure Attentions	Error are leaded into all frequency counters when measuring low voltage or low frequency signal.	
Capacitance Measuring		
Measurement Method	Measure the rate of change of voltage generated during the current flowing the capacitance	
Connection Type	2-wire	
Input Protection	1000 V on all ranges	
Temperature Measuring		
Measurement Method	Support for TC and RTD types of sensor	
Trigger and Memory		
Samples/Trigger	1 ~ 10000	
Trigger Delay	6 ms ~ 10000 ms optional	
External Trigger Input	Input Level	TTL compatible (High level when left input terminal is hanging in the air)
	Trigger Condition	Rising and Falling selectable
	Input Impedance	\geq 20 K Ω //400 pF ,DC-coupled
	Min Pulse	500 us
VMC	Level	TTL compatible
	Output Polarity	Straight and negative optional
	Output Impedance	200 Ω , typical

History Records

Volatile Memory	10 K reading of history records
Nonvolatile Memory	1 Gb Nand Flash, Mass storage configuration files and data files, Support U-disk external storage

Math Functions

Min/Max/Average, dBm, dB, Pass/Fail, Relative, Standard deviation, Hold, histogram, Trend chart, Bar chart

General Specifications

Power Supply

AC 100 V ~ 120 V	45 Hz ~ 66 Hz
AC 200 V ~ 240 V	45 Hz ~ 66 Hz
Consumption	20VA max

Mechanism

Dimension	293.75 mm×260.27 mm×107.21 mm
Weight	3.76 Kg

Other Characteristics

Display Screen	4.3" TFT-LCD with resolution 480*272
Operation Environment	Full accuracy from 0°C to 50°C , 80% RH and 40°C , non condensing
	Storage Temperature: -20°C -70°C
	Shock and Vibration: conforming to MIL-T-28800E, , 5 level (only foe sine) Height above sea level: up to 3000 meters
electromagnetic compatibility	Conforming to EMC (2004/108/EC) and EN 61326-1:2013
Safety	Conforming to EN61010-1:2010 and low voltage instructions (2006/95/EC)
Remote Interface	10/100 Mbit LAN, USB2.0 Full Speed Device and Host
Programmer Language	Standard SCPI, compatible with commands of main stream multimeters
Warm Up Time	30 minutes

Purchase Information

Product name

SIGLENT SDM3045X Digital Multimeter

Models	SDM3045X
Standard Accessories	A power Cord that fits the standard of destination country
	Two Test Leads, Two Alligator Clips
	A USB Cable
	A Quick Start
	A Guaranty Card
	A CD (Including EasySDM computer software system)

SDM3045X Digital Multimeter



About SIGLENT

SIGLENT is an international high-tech company, concentrating on R&D, sales, production and services of electronic test & measurement instruments.

SIGLENT first began developing digital oscilloscopes independently in 2002. After more than a decade of continuous development, SIGLENT has extended its product line to include digital oscilloscopes, function/arbitrary waveform generators, digital multimeters, DC power supplies, spectrum analyzers, isolated handheld oscilloscopes and other general purpose test instrumentation. Since its first oscilloscope, the ADS7000 series, was launched in 2005, SIGLENT has become the fastest growing manufacturer of digital oscilloscopes. We firmly believe that today SIGLENT is the best value in electronic test & measurement.

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